

**Search Notes**

Application/Control No.

10/606,350

Examiner

Philip Gabler

Applicant(s)/Patent under  
Reexamination

MAEKAWA ET AL.

Art Unit

3637

**SEARCHED**

Class	Subclass	Date	Examiner
312	7.2,8.16	9/12/2005	JTN
108	50.11	9/12/2005	JTN
181	198,199	9/12/2005	JTN
181	148,150	9/15/2005	JTN
181	156	9/15/2005	JTN
381	301,386	9/15/2005	JTN
381	306,345	9/15/2005	JTN
381	349,388	9/15/2005	JTN
D14	172,194	9/12/2005	JTN
D14	204,221	9/12/2005	JTN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search	9/12/2005	JTN
if allowable, classify in 181/148,199; 381/301,388 per Edgardo San Martin	9/15/2005	JTN
update search	2/8/2006	PFG